


<b>Search Notes</b>  	<b>Application/Control No.</b>  10821454	<b>Applicant(s)/Patent Under Reexamination</b>  WANG, CHANGZHOU
	<b>Examiner</b>  Joseph P Hirl	<b>Art Unit</b>  2129

SEARCHED			
Class	Subclass	Date	Examiner
706	14, 45, 47, @ad<20040409	2/26/8	JPH
707	6, @ad<20040409	2/26/8	JPH

SEARCH NOTES		
Search Notes	Date	Examiner
East: all data bases, time series, time-stamped, cardinality, occurrence , pattern	2/26/8	JPH
IEEE, time series, pattern	2/26/8	JPH
Inventor: Wang	2/26/8	JPH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner